Sear	rch N	lotes	

Application/Control No.	Applicant(s)/Patent und Reexamination	der
10/002,620	SAKAMOTO ET AL.	
Examiner	Art Unit	
C. SAYALA	1761	

SEARCHED			
Class	Subclass	Date	Examiner
71	28	5/1/2006	cs
	32		
	44		
	64.03		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
71	28, 32	5/1/2005	cs
	44		
	64.03		

SEARCH N (INCLUDING SEAR)		Y)
	DATE	EXMR
Search transcript attached	5/1/2006	cs
•		